



SLD160N03T 30V N -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Application

☑PWM Application☑Load Switch☑Power Management

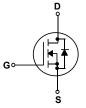
Features

- N-Channel:30V 160A

 $\begin{array}{l} R_{DS(on)Typ} = 1.9 m \Omega @V_{GS} = 10 \ V \\ R_{DS(on))Typ} = 2.6 m \Omega @V_{GS} = 4.5 V \end{array}$

- Very Low On-resistance R_{DS(ON)}
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter	SLD160N03T	Units
V _{DSS}	Drain-Source Voltage	30	V
	Drain Current - Continuous (T _C = 25°C)	160	Α
l _D	- Continuous (T _C = 100°C)	104	Α
I _{DM}	Drain Current - Pulsed (Note 1)	480	Α
V_{GSS}	Gate-Source Voltage	±20	V
Eas	Single Pulsed Avalanche Energy (Note 2)	730	mJ
P _D	Power Dissipation (T _C = 25°C)	92	W
Rелс	Thermal Resistance, Junction to Case	1.36	°C/W
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

^{*} Drain current limited by maximum junction temperature.

Package Marking

Symbol

	Part Number	Top Marking	Package	Packing Method	MOQ	QTY
ĺ	SLD160N03T	SLD160N03T	D-Pak	Tape & Reel	2500	25000

Electrical Characteristics

T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \text{ uA}$	30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30 V, V _{GS} = 0 V			1	uA
I_{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20V, V _{DS} = 0 V			100	nA
Iceep	Gate-Body Leakage Current Reverse	$V_{CS} = -20 \text{ V} V_{DS} = 0 \text{ V}$			-100	nΑ

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \text{ uA}$	1.0	1.6	2.2	V
R _{DS(on)}	Static Drain-Source	V _{GS} = 10 V, I _D = 20A	1.9	2.2	0	
	On-Resistance	V _{GS} = 4.5 V, I _D = 15A	-	2.6	3.2	mΩ

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	-	7249	1	pF
Coss	Output Capacitance			689	-	pF
Crss	Reverse Transfer Capacitance	1.0 Will2		680	-	рF

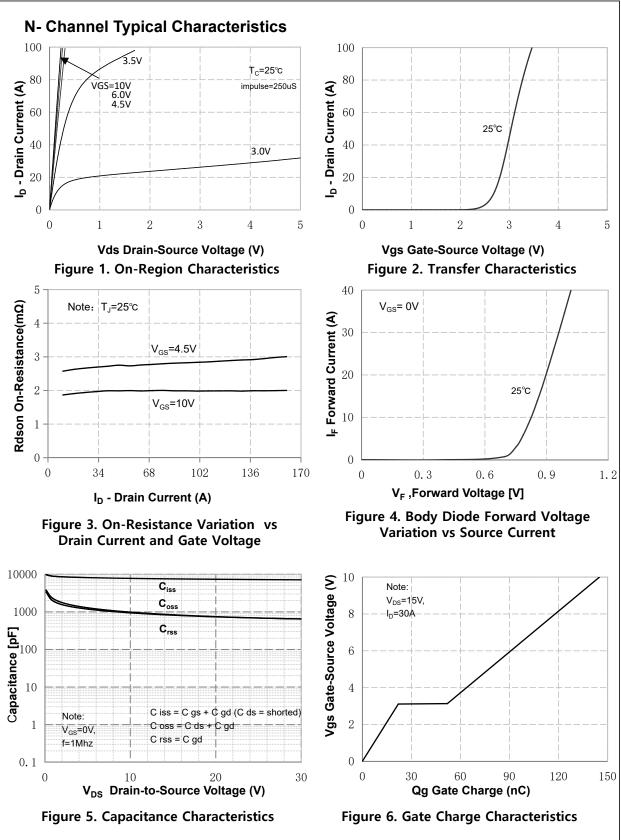
Switching Characteristics

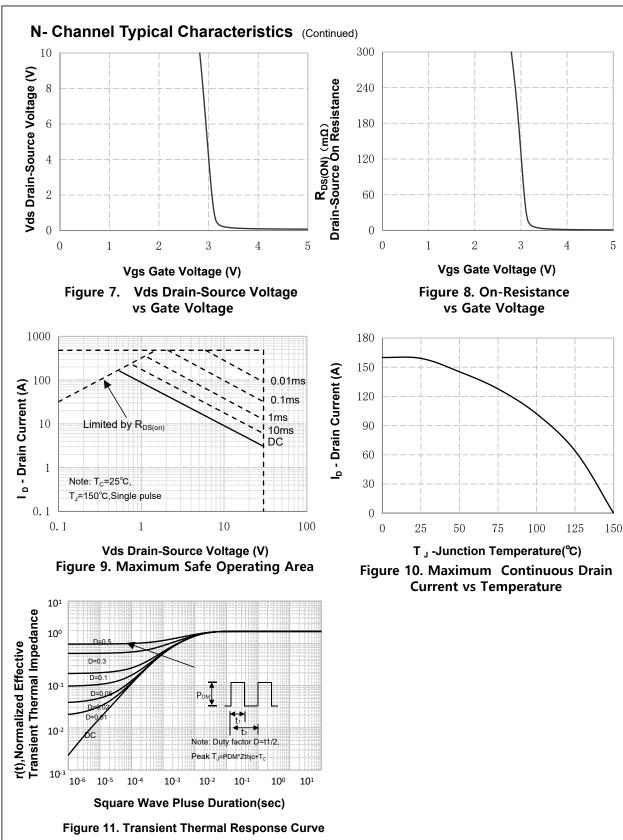
$t_{d(on)}$	Turn-On Delay Time		 13		ns
t _r	Turn-On Rise Time	V _{GS} = 4.5 V, V _{DS} =15 V,	 130	-	ns
$t_{d(off)}$	Turn-Off Delay Time	$R_G = 1.8\Omega, I_D = 60A$ (Note 3)	 30		ns
t_f	Turn-Off Fall Time		 66	-	ns
Q_g	Total Gate Charge	$V_{DS} = 15 \text{ V}, I_{D} = 30 \text{A},$	 145	-	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10V$ (Note 3)	 29	-	nC
Q_{gd}	Gate-Drain Charge		 22		nC
R_{G}	Gate Resistance	f = 1MHz	 1.2		Ω

Drain-Source Diode Characteristics and Maximum Ratings

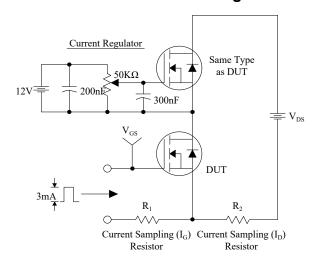
Is	Maximum Continuous Drain-Source Diode Forward Current	-		160	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current	1	-	480	Α
V_{SD}	Drain to Source Diode Forward Voltage, V _{GS} = 0V, I _{SD} = 30A, T _J = 25°C	-		1.2	V
t _{rr}	Reverse Recovery Time &T $_{J}$ = 25°C, I $_{F}$ = 80A di/dt = 100A/ μ s	1	60	-	nS
Q _{rr}	Reverse Recovery Charge & T _J = 25°C, I _F = 80A di/dt = 100A/µs		115		nC

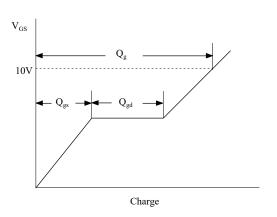
- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition: T $_J$ =25°C, V_{DD} =15V, V_G =10V, R_G =25 Ω , L=0.5mH,
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



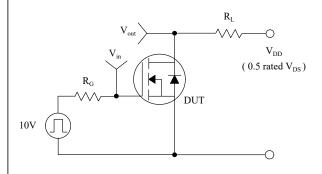


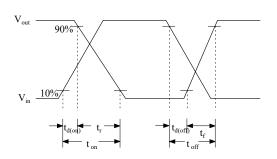
Gate Charge Test Circuit & Waveform



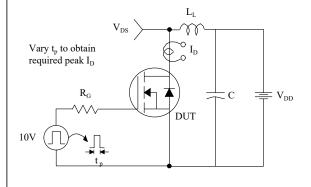


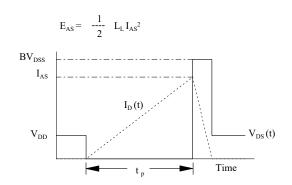
Resistive Switching Test Circuit & Waveforms



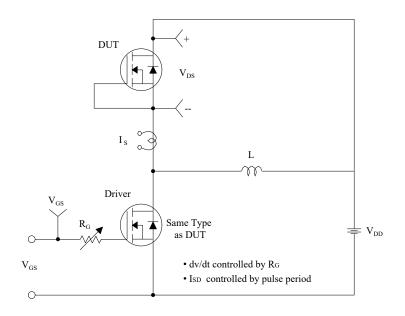


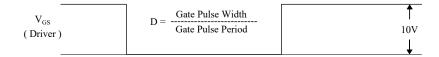
Unclamped Inductive Switching Test Circuit & Waveforms

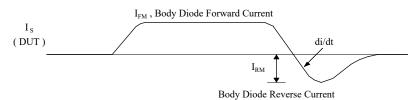


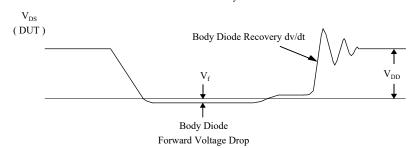


Peak Diode Recovery dv/dt Test Circuit & Waveforms

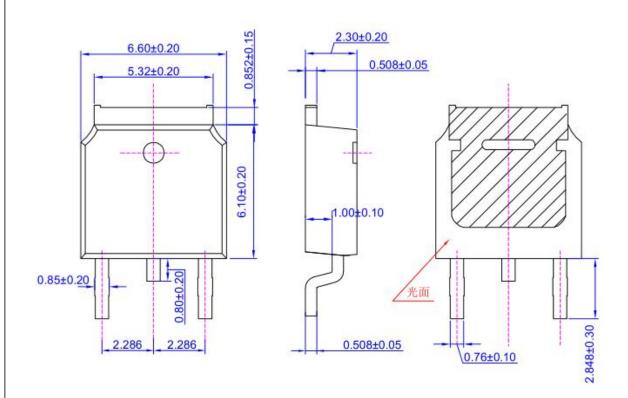


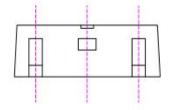






TO-252 OUTLINE





NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8 2.Undeclared tolerance \pm 0.25,Unmarked filletRmax=0.25

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